Preferred Device

Sensitive Gate Silicon Controlled Rectifiers

Reverse Blocking Thyristors

Designed for high volume, low cost, industrial and consumer applications such as motor control; process control; temperature, light and speed control.

Features

- Pb-Free Package is Available
- Small Size
- Passivated Die for Reliability and Uniformity
- Low Level Triggering and Holding Characteristics
- Epoxy Meets UL 94, V-0 @ 0.125 in
- ESD Ratings: Human Body Model, 3B > 8000 V Machine Model, C > 400 V

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Note 1) (T _J = –40 to 110°C, Sine Wave, 50 to 60 Hz, Gate Open)	V _{DRM,} V _{RRM}		V
MCR12DSM MCR12DSN		600 800	
On–State RMS Current (180° Conduction Angles; T _C = 75°C)	I _{T(RMS)}	12	Α
Average On–State Current (180° Conduction Angles; T _C = 75°C)	I _{T(AV)}	7.6	Α
Peak Non-Repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, T _J = 110°C)	I _{TSM}	100	А
Circuit Fusing Consideration (t = 8.3 msec)	l ² t	41	A ² sec
Forward Peak Gate Power (Pulse Width ≤ 1.0 µsec, T _C = 75°C)	P _{GM}	5.0	W
Forward Average Gate Power (t = 8.3 msec, T _C = 75°C)	P _{G(AV)}	0.5	W
Forward Peak Gate Current (Pulse Width ≤ 1.0 µsec, T _C = 75°C)	I _{GM}	2.0	Α
Operating Junction Temperature Range	T_J	-40 to 110	°C
Storage Temperature Range	T _{stg}	-40 to 150	°C

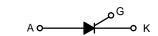
Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the device are exceeded.



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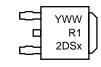
SCRs 12 AMPERES RMS 600 – 800 VOLTS



MARKING DIAGRAMS

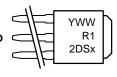


DPAK CASE 369C STYLE 4





DPAK-3 CASE 369D STYLE 4



Y = Year WW = Work Week x = M or N

PIN ASSIGNMENT				
1	Cathode			
2	Anode			
3	Gate			
4	Anode			

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

Preferred devices are recommended choices for future use and best overall value.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance – Junction–to–Case – Junction–to–Ambient – Junction–to–Ambient (Note 2)	R _{θJC} R _{θJA} R _{θJA}	2.2 88 80	°C/W
Maximum Lead Temperature for Soldering Purposes (Note 3)	T_L	260	°C

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise noted)

Characteristics	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Peak Repetitive Forward or Reverse Blocking Current (N $(V_{AK} = Rated V_{DRM} \text{ or } V_{RRM}; R_{GK} = 1.0 K\Omega)$	I _{DRM} , I _{RRM}		_ _	10 500	μΑ	
ON CHARACTERISTICS						
Peak Reverse Gate Blocking Voltage, ($I_{GR} = 10 \mu A$)		V_{GRM}	10	12.5	18	V
Peak Reverse Gate Blocking Current, (V _{GR} = 10 V)		I _{GRM}	_	-	1.2	μΑ
Peak Forward On–State Voltage (Note 5), (I _{TM} = 20 A)		V _{TM}	-	1.3	1.9	V
Gate Trigger Current (Continuous dc) (Note 6) $(V_D = 12 \text{ V}, R_L = 100 \Omega)$	$T_J = 25^{\circ}C$ $T_J = -40^{\circ}C$	I _{GT}	5.0 -	12 -	200 300	μΑ
Gate Trigger Voltage (Continuous dc) (Note 6) $(V_D = 12 \text{ V}, \text{ R}_L = 100 \Omega) \\ T_J = 25^{\circ}\text{C} \\ T_J = -40^{\circ}\text{C} \\ T_J = 110^{\circ}\text{C}$		V _{GT}	0.45 - 0.2	0.65 - -	1.0 1.5 –	V
Holding Current ($V_D = 12 \text{ V}$, Initiating Current = 200 mA, Gate Open) $T_J = 25^{\circ}\text{C}$ $T_J = -40^{\circ}\text{C}$		lн	0.5 -	1.0	6.0 10	mA
Latching Current $(V_D = 12 \text{ V}, \text{ I}_G = 2.0 \text{ mA}) \\ T_J = 25^{\circ}\text{C} \\ T_J = -40^{\circ}\text{C}$		ΙL	0.5	1.0	6.0 10	mA
Turn–On Time (Source Voltage = 12 V, R_S = 6.0 KΩ, I_T = 16 A(pk), R_{GK} = 1.0 KΩ) (V_D = Rated V_{DRM} , Rise Time = 20 ns, Pulse Width = 10 μs)		tgt	-	2.0	5.0	μs

DYNAMIC CHARACTERISTICS

Characteristics	Symbol	Min	Тур	Max	Unit
Critical Rate of Rise of Off–State Voltage	dv/dt	2.0	10		V/μs
$(V_D = 0.67 \text{ X Rated } V_{DRM}, \text{ Exponential Waveform}, $ $R_{GK} = 1.0 \text{ K}Ω, T_J = 110$ °C)		2.0	10	_	

^{2.} These ratings are applicable when surface mounted on the minimum pad sizes recommended.

ORDERING INFORMATION

Device	Package Type	Package	Shipping [†]
MCR12DSMT4	DPAK	369C	16 mm Tape & Reel (2.5 k / Reel)
MCR12DSMT4G	DPAK (Pb-Free)	369C	16 mm Tape & Reel (2.5 k / Reel)
MCR12DSN-001	DPAK-3	369D	75 Units / Rail
MCR12DSNT4	DPAK	369C	16 mm Tape & Reel (2.5 k / Reel)

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{3. 1/8&}quot; from case for 10 seconds.

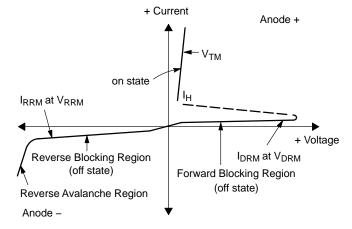
^{4.} Ratings apply for negative gate voltage or R_{GK} = 1.0 kΩ. Devices shall not have a positive gate voltage concurrently with a negative voltage on the anode. Devices should not be tested with a constant current source for forward and reverse blocking capability such that the voltage applied exceeds the rated blocking voltage.

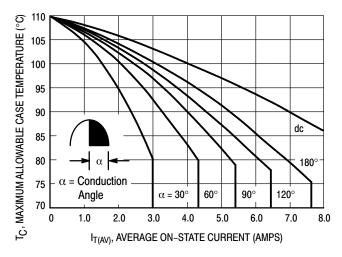
^{5.} Pulse Test: Pulse Width \leq 2.0 msec, Duty Cycle \leq 2%.

^{6.} R_{GK} current not included in measurement.

Voltage Current Characteristic of SCR

Symbol	Parameter
V_{DRM}	Peak Repetitive Off State Forward Voltage
I _{DRM}	Peak Forward Blocking Current
V_{RRM}	Peak Repetitive Off State Reverse Voltage
I _{RRM}	Peak Reverse Blocking Current
V_{TM}	Peak On State Voltage
I _H	Holding Current





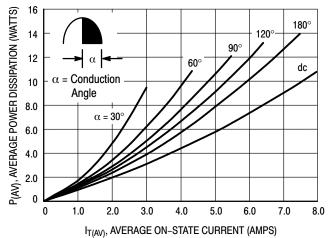


Figure 1. Average Current Derating

Figure 2. On-State Power Dissipation

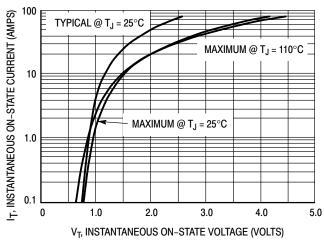
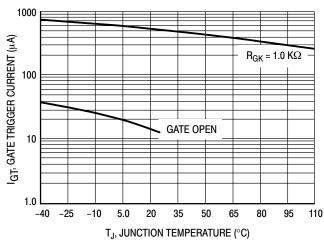


Figure 3. On-State Characteristics

Figure 4. Transient Thermal Response



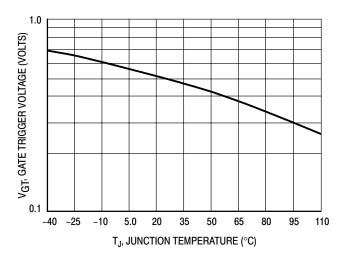
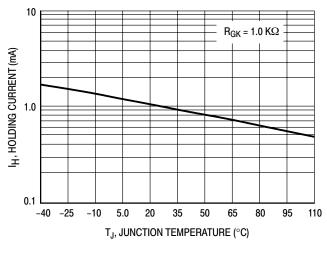


Figure 5. Typical Gate Trigger Current versus Junction Temperature

Figure 6. Typical Gate Trigger Voltage versus Junction Temperature



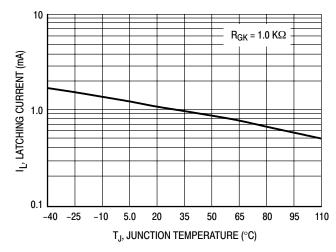


Figure 7. Typical Holding Current versus Junction Temperature

Figure 8. Typical Latching Current versus Junction Temperature

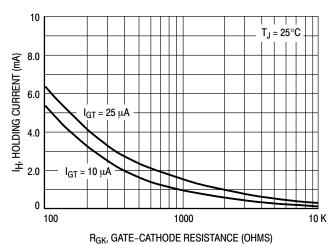


Figure 9. Holding Current versus Gate-Cathode Resistance

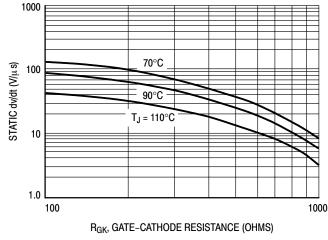


Figure 10. Exponential Static dv/dt versus

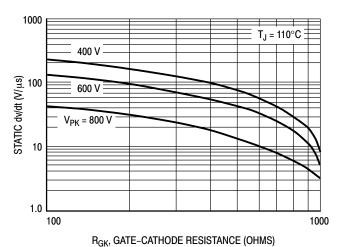
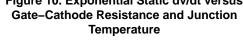
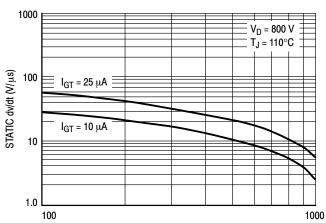


Figure 11. Exponential Static dv/dt versus Gate-Cathode Resistance and Peak Voltage



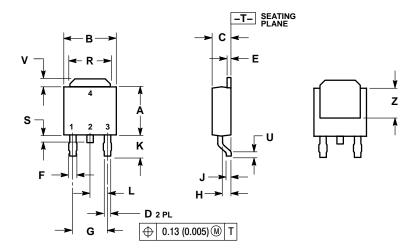


R_{GK}, GATE-CATHODE RESISTANCE (OHMS)

Figure 12. Exponential Static dv/dt versus Gate-Cathode Resistance and Gate Trigger Current Sensitivity

PACKAGE DIMENSIONS

DPAK CASE 369C **ISSUE O**

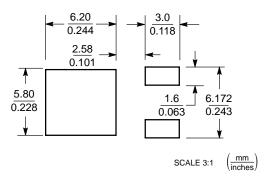


- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180	BSC	4.58 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090	BSC	2.29	BSC
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 4: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE

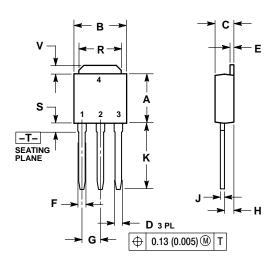
SOLDERING FOOTPRINT*

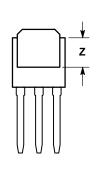


^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

DPAK-3 CASE 369D-01 **ISSUE B**





- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INCHES		HES MILLIMETER	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

- STYLE 4:
 PIN 1. CATHODE
 2. ANODE
 3. GATE
 4. ANODE